

This is a Request for Quote (RFQ) from domestic (India-based), for the supply and installation of Focused Ion Beam at MNCF, CeNSE, IISc Bangalore. CeNSE, IISc is seeking to replace the current FIB tool, which near the end of its useful life

Section 1 - Bid Schedule

1	Tender No	
2	Tender Date	14 th June 2021
3	Item Description	Supply and installation of Focused Ion Beam at MNCF, CeNSE, IISc Bangalore
4	Tender Type	Two bid system (i) Technical Bid (Part A) (ii) Commercial Bid (Part B)
5	Place of tender submission	Chairperson Office First Floor Centre for Nano Science and Engineering Indian Institute of Science, Bangalore 560012
6	Last Date & Time for submission of tender	04 th July 2021
7	For further clarification	Dr. Suresha S J MNCF Centre for Nano Science and Engineering Indian Institute of Science, Bangalore 560012 Email: sureshasj@iisc.ac.in Phone: +91 80 2293 3253

Section 2 – Eligibility Criteria

Prequalification criteria:

1. The Bidder's firm should have existence for a minimum of 5 years. (Enclose Company Registration Certificate)
2. The Bidder should belong to either class 1 or class 2 supplier distinguished by their "local content" as defined by recent edits to GFR. They should mention clearly which class they belong to in the cover letter.
 - a) Class 1 supplier: Goods and services should have local content of equal to or more than 50%.
 - b) Class 2 supplier: Goods and services should have local content of equal to or more than 20 % and less than 50%.
3. Quote should come only from Indian Original Equipment Manufacturer (OEM) or their Indian authorized distributor.
4. The quotations should be on FOR-IISc Bangalore basis in INR only.
5. Bidders offering imported products will fall under category of Non-local suppliers. They cannot claim themselves as Class-1 local supplier/Class-II local suppliers by claiming the services such as transportation, Insurance, installation, commissioning, training, and other sales service support like AMC/CMC etc as local value addition.
6. Purchase preference as defined by the recent edits to GFR (within the "margin of purchase preference") will be given to Class-1 supplier.
7. MSME can seek exemption to some qualification criteria. IISc follows GFR2017 for such details
8. The bidder should sign and submit the declaration for Acceptance of Terms and Conditions as per -Annexure 4.
9. The Bidder must not be blacklisted/banned/suspended or have a record of any service-related dispute with any organization in India or elsewhere. A declaration to this effect has to be given as per Annexure 3.

Section 3 – Terms and Conditions

A) Submission of Tender:

1. All documentations in the tender should be in English.
2. Tender should be submitted in two envelopes (two bid system).
 - a. Technical Bid (Part-A) – Technical bid consisting of all technical details and check list for conformance to technical specifications.

The technical proposal should contain a technical compliance table with 5 columns.

- i. The first column must list the technical requirements, in the order that they are given in the technical requirement below.
 - ii. The second column should provide specifications of the instrument against the requirement. Please provide quantitative responses wherever possible.
 - iii. The third column should describe your compliance with a “Yes” or “No” only. Ensure that the entries in column 2 and column 3 are consistent.
 - iv. The fourth column should state the reasons/explanations/context for deviations, if any.
 - v. The fifth column can contain additional remarks from the OEM. You can use this opportunity to highlight technical features, qualify response of previous columns, or provide additional details, compare your solution with that of your competitors or provide details as requested in the technical requirements table below.
- b. Commercial Bid (Part-B) – Indicating item wise price for the items mentioned in the technical bid, **as per the format of quotation provided in tender**, and other commercial terms and conditions.

3. The technical bid and price bid should each be placed in separate sealed covers, superscripting on both the envelopes the tender no. and the due date. Both these sealed covers are to be placed in a bigger cover which should also be sealed and duly superscripted with the Tender No, Tender Description & Due Date.
4. The SEALED COVER superscripting tender number / due date & should reach Chairperson Office, Centre for Nanoscience and Engineering, Indian Institute of Science, Bangalore – 560012, India on or before due date mentioned in the tender notice. In case due date happens to be holiday the tender will be accepted and opened on the next working day. If the quotation cover is not sealed, it will be rejected.
5. All queries are to be addressed to the person identified in “Section 1 – Bid Schedule” of the tender notice.
6. The items are required for research purposes, and IISc is a DSIR registered institution, hence eligible for GST exemption (i.e. GST @ 5%). While submitting the price quote, this point must be taken care. For getting GST exemption certificate, successful bidders must submit, a formal request together with Invoice copy and Purchase order copy.

7. GST/other taxes, levies etc., are to be indicated separately. The BIDDER should mention GST Registration and PAN in the tender document.
8. If price is not quoted in Commercial Bid as per the format provided in tender document the bid is liable to be rejected.
9. The purchase committee reserves the right to accept or reject any bid and to annul the bidding process and reject all bids at any time prior to the award of contract, without there by incurring any liability to the affected bidder or bidders or any obligation to inform the affected bidder or bidders.
10. Incomplete bids will be summarily rejected.

B) Cancellation of Tender:

Notwithstanding anything specified in this tender document, IISc purchase committee, in its sole discretion, unconditionally and without having to assign any reason, reserves the rights:

- a. To accept OR reject lowest tender or any other tender or all the tenders.
- b. To accept any tender in full or in part.
- c. To reject the tender, offer not confirming to the tender terms.

C) Validity of the Offer:

The offer shall be valid 90 Days from the date of opening of the commercial bid.

D) Evaluation of Offer:

1. The technical bid (Part A) will be opened first and evaluated.
2. Bidders meeting the required eligibility criteria as stated in Section 2 of this document shall only be considered for Commercial Bid (Part B) opening. Further, agencies not furnishing the documentary evidence as required will not be considered.
3. Pre- qualification of the bidders shall not imply final acceptance of the Commercial Bid. The agency may be rejected at any point during technical evaluation or during commercial evaluation. The decision in regard to acceptance and / or rejection of any offer in part or full shall be the sole discretion of IISc Bangalore, and decision in this regard shall be binding on the bidders.
4. The award of contract will be subject to acceptance of the terms and conditions stated in this tender.
5. Any offer which deviates from the vital conditions (as illustrated below) of the tender is liable to be rejected:
 - a. Non-submission of complete offers.
 - b. Receipt of bids after due date and time and or by email / fax (unless specified otherwise).

- c. Receipt of bids in open conditions.
6. In case any BIDDER is silent on any clauses mentioned in these tender documents, IISc Bangalore shall construe that the BIDDER had accepted the clauses as of the tender and no further claim will be entertained.
7. No revision in the terms and conditions quoted in the offer will be entertained after the last date and time fixed for receipt of tenders.
8. Lowest bid will be calculated based on the total price of all items tendered for Basic equipment along with accessories selected for installation, operation, preprocessing and post processing, optional items, recommended spares, warranty, annual maintenance contract. The purchase committee is looking for the most cost-effective solution of obtaining a new tool. Vendors are encouraged to propose all avenues, including but not limited to buy back of the exiting tool, turnkey upgrade of existing tool or purchase of a new tool.

E) Pre-requisites:

The bidder will provide the prerequisite installation requirement of the equipment along with the technical bid.

F) Warranty:

The complete system is to be under warranty period of minimum 3 years (year wise breakup value should be shown in the commercial bid) Vendor should include cost of any spares that are expected to be needed during the warranty period, including electronics, subcomponents, and software. Vendors can assume usage of 2000 hours/year for this calculation. If the instrument is found to be defective, it has to be replaced or rectified at the cost of the bidder within 30 days from the date of receipt of written communications from IISc, Bangalore. If there is any delay in replacement or rectification, the warranty period should be correspondingly extended.

G) Annual Maintenance Contract:

An annual maintenance contract for a period of at least 3 years post warranty should be provided as an essential optional item on completion of warranty period.

The AMC costs will not be considered towards classifying the domestic nature (class 1 or class 2) of the vendor (see eligibility criteria in section 2).

H) Buy Back:

CeNSE, IISc is seeking to replace the current FIB tool, which near the end of its useful life. CeNSE, IISc has Dual Beam FIB Helios NanoLab 600i (FEI) installed in 2011. The vendors are requested to include buyback offer (Optional)

I) Purchase Order:

1. The quantity of the items in tender is only indicative. IISc, Bangalore reserves the right to increase /decrease the quantity of the items depending on the requirement.
2. If the quality of the product and service provided is not found satisfactory, IISc, Bangalore reserves the right to cancel or amend the contract.

J) Delivery, Installation and Training:

The bidder shall provide the lead time to delivery, installation and made functional at IISc, Bangalore from the date of receipt of purchase order. The system should be delivered, installed and made functional within 90 days from the date of receipt of purchase order. The supply of the items will be considered as effected only on satisfactory installation and inspection of the system and inspection of all the items and features/capabilities tested by the IISc, Bangalore. After successful installation and inspection, the date of taking over of entire system by the IISc, Bangalore shall be taken as the start of the warranty period. No partial shipment is allowed.

The bidder should also arrange for technical training to the local facility technologists and users.

K) Payment Terms:

100% payments (except AMC) will be released after completion delivery and satisfactory installation subject to TDS as per rules. AMC cost (if ordered), after completion of warranty period) will be released on half-yearly basis at the end of each six months subject to satisfactory services. Price basis must be on FOR-IISc Bangalore basis only.. As per GFR no advance payment can be made to domestic vendors, unless an equal amount of bank guarentee is provided.

L) Statutory Variation:

Any statutory increase in the taxes and duties subsequent to bidder's offer, if it takes place within the original contractual delivery date, will be borne by IISc, Bangalore subject to the claim being supported by documentary evidence. However, if any decrease takes place the advantage will have to be passed on to IISc, Bangalore.

M) Disputes and Jurisdiction:

Any legal disputes arising out of any breach of contract pertaining to this tender shall be settled in the court of competent jurisdiction located within the city of Bangalore, India.

N) General:

1. All amendments, time extension, clarifications etc., within the period of submission of the tender will be communicated electronically. No extension in the bid due date/time shall be considered on account of delay in receipt of any document(s) by mail.
2. The bidder may furnish any additional information, which is necessary to establish capabilities to successfully complete the envisaged work. It is however, advised not to furnish superfluous information.
3. The bidder may visit the installation site before submission of tender, with prior intimation.

4. Any information furnished by the bidder found to be incorrect, either immediately or at a later date, would render the bidder liable to be debarred from tendering/taking up of work in IISc, Bangalore.

Section 4 – Technical Specifications

Item	Requirement	Indicate compliance	Provide information
Electron Column			
Electron beam source	Schottky field emitter		
Electron beam Voltage range	350V or less- 30kV or more		Step size
Electron beam Current range	1 pA or less to 300 nA or more		Continuous/ stepped Step size
Electron beam Landing voltage	50 V or less to 30 kV or more		Methodology for deceleration
Magnification	800000 x or more		
Resolution	<p>At dual beam coincidence point at accelerating voltage of</p> <ul style="list-style-type: none"> • 0.7 nm at 30 kV STEM or better • 1.4 nm at 1 kV or better <p>Best achievable resolution at accelerating voltage of</p> <ul style="list-style-type: none"> • 30/20 keV • 15 keV • 1keV • better than 1.5 nm at all keV 		<p>Provide information</p> <p>State working distance and all operational parameters, such as aperture size etc, probe current, probe size</p> <p>state for immersion lens if and non-immersion lens if applicable</p> <p>state detector configuration</p>

Electron Beam probe size			Probe size vs probe current Continuous or stepped Step size
Electron beam current stability			Provide information
Magnetic samples	Strategies for magnetic field free imaging		Describe for information
Apertures, aperture sizes and insertion and retraction methods			Provide information
Image acquisition system:	Image acquisition size Bit depth Electronic Image shift Dynamic focus for stage tilt		provide information
Scan features	Point and line scan Focus Window Image rotation, shift tilt compensation Scan speed		Provide description Range, stepped or continuous
Field of View	Maximum without distortion		State operation parameters
Ion column			
Ion source	Ga liquid metal ion source Source with 3000 μ amp lifetime / 3x1000 μ amp hours or more		
Ion beam voltage	2000 V or less to 30 kV or more		Stepped or continuous State step size if applicable
Ion beam current	1 pA or less to 60 nA or more		Stepped or continuous State step size if applicable
Ion beam resolution	3 nm at 30 kV or better		
Probe size			Provide minimum probe size Provide probe size vs current data

Ion beam profile	Circularity is important Significant venation from circularity will because for disqualification		Provide tiff images at Combinations of high and low Probe currents and sizes on a Standard Si sample
Ion beam milling rate	for Si $\geq 0.25 \mu\text{m}^3/\text{nC}$		State operational parameters
SEM-FIB angle			For information
Magnification			For information
Working distance at dual beam coincidence point			For information
Ion beam apertures			Indicate sizes, movements and centering methodologies
Spatial resolution	At dual beam coincident point At accelerating voltages of 30 kV 5 nm or less		Indicate all operating conditions such as current, probe size, working distance, standard sample
Ion beam image acquisition size and performance	Image size and bit depth: Image shift:		provide information
Beam control	Rotating the ion beam raster in a 360-degree continuous fashion and shall have a function to reset this rotation to 0 degrees. Capable of reduced-raster, spot-mode, and line-scan ion-imaging modes Users should have the options to define raster		

	trajectories, spot overlap and defocus values.		
IMAGING DETECTORS FOR ELECTRON AND ION BEAM COLUMNS			
Secondary electron detectors at various locations			
In column/lens Detector SE			
In column/lens Detector BSE (optional)			
In chamber IR camera			
Probe current measurement			
Retractable STEM detector	The retractable STEM detector enables scanning transmission imaging on thin samples in SEM		
In chamber Navigation camera	Navigation color optical camera can be used to take top-down images of samples for navigation		
TEM AND ATOM PROBE SAMPLE PREPARATION			
Requirements	In situ micromanipulator for transmission electron microscopy (TEM) under computer control without operator intervention. Pneumatic insertion and retraction		
Micromanipulator performance	In situ manipulator with 4 degrees of freedom including on axis rotation		
	Manipulator should be with high precision, stability, and motorized needle rotation for easy preparation of ultra-thin TEM samples		

	Drift, vibration, repeatability		Provide information
GAS INJECTION SYSTEM & STAGE			
Requirements	A gas injection system with three injection modules enabling beam induced Pt, W and C deposition		
Stage	<p>A stage with motorized axes with adequate degrees of free demo required for the accurate positioning of the needle in the working area.</p> <p>Motorised stage with X and Y movements 110 mm or greater, Z movement 60 mm or greater, rotation 360 degrees and tilt range: -10 to 90⁰ or greater. Compeucentric rotation option should be available</p> <p>Automated nozzle positioning and angle</p> <p>Injection line must allow precise control over gas flow, and heating of individual lines</p> <p>The stage must be capable of depositing Finely spaced Nano sized deposits in arrays at spacing's of at least ¼ micron.</p>		Provide detailed description
Precursors	Standard reservoir for Pt, W and C (may be Au)		
SAMPLE STAGE AND HOLDER REQUIREMENTS			
Main chamber size			Provide information

Maximum sample size	Considering use of electron and ion column (at coincident point) and all necessary tilt angles for milling and other detector restrictions		Provide information
Stage performance	Stage movement comp centric rotation where stage rotation is accompanied by X and Y translation to maintain the same sample field of view during stage rotation.		Provide information on sample movement and rotation limits
Holders	Standard holders Specialized holders with precise pre tilt angles suitable for imaging with BDSE/SE without sample movement are required.		Provide information on maximum /minimum sample dimensions, shape restrictions and weight restrictions for each holder
	The vendor will indicate the accuracy of and precision of such stage moments to enable precise return without backlash to original positions		
Ports	More than 20 available ports on chamber for future upgradation		Provide information
Vacuum System			
System description			Provide complete description of system in response
System requirements	Oil free system electron gun, accelerator region and any differential pumping chambers shall be continuously evacuated by ion pumps Column components and chambers below the		

	<p>electron gun and ion gun will be evacuated turbo molecular pumps or equivalent oil-free system.</p> <p>Mechanical pumps used to achieve rough vacuum levels will prevent back-streaming of oil into the vacuum system</p>		
	Chamber vacuum		provide information
	Gun Vacuum		provide information
	FIB gun vacuum		provide information
	Pumping rate of main chamber		provide information
SUPPORTING SOFTWARES			
Ion Beam support Data	Files containing Ga beam etch rates for Most standard metal sand alloys (viz., Fe, Ti, Ni, Cr, Si, Al, Steel, SiN, SiC etc.) Must be present in the system		
Software supporting Stakeholder movements for automated functions			
Software to automate the TEM sample preparation (Optional)			
Software supporting detector configurations that enhance analysis of SE, BSE and Ion Images.			
Free s/w upgrades for 7 years after equipment installation and acceptance			
Functional details of each software package			provide information
AUXILIARY EQUIPMENT			

<p>The supplier will provide any auxiliary cooling required for equipment cooling such as water chillers</p>			
<p>SITE PREPARATION REQUIREMENTS</p>			
<p>The chosen supplier shall indicate all site requirements including those for stable equipment operation within one month of order placement</p>			
<p>It is the responsibility of IISc to ensure that the site meets with all specifications of the supplier in time for equipment installation</p>			

<p>Spares</p>			
<p>Spare FEG source</p>			
<p>Long-life Ga source</p>			
<p>Spare stubs– 100 nos</p> <p>45°, 70-degree pre-tilt holders (4nos. each)</p> <p>Supplier will, indicate any additional spares required for one year trouble free operation</p>			

Section 5- Technical Bid

The technical bid should furnish all requirements of the tender along with all annexures in this section and submitted to

The Chairperson,

Attn: Dr. Suresha S J

Centre for Nano Science and Engineering

Indian Institute of Science

Bangalore – 560012, India

Annexure-1:

Details of the Bidder

The bidder must provide the following mandatory information & attach supporting documents wherever mentioned:

Details of the Bidder

Sl. No	Items	Details
1.	Name of the Bidder	
2.	Nature of Bidder (Attach attested copy of Certificate of Incorporation/ Partnership Deed)	
3.	Registration No/ Trade License, (attach attested copy)	
4.	Registered Office Address	
5.	Address for communication	
6.	Contact person- Name and Designation	
7.	Telephone No	
8.	Email ID	
9.	Website	
10.	PAN No. (attach copy)	
11.	GST No. (attach copy)	

Signature of the Bidder

Name
Designation, Seal

Date:

Annexure-2:

Declaration regarding experience

To,
The Chairperson,
Centre for Nanoscience and Engineering,
Indian Institute of Science,
Bangalore – 560012, India

Ref: Tender No: XXXXXXXXX

Dated: XXXXX

Supply and installation of Focused Ion Beam at MNCF, CeNSE, IISc Bangalore
Sir,

I've carefully gone through the Terms & Conditions contained in the above referred tender. I hereby declare that my company / firm has ---- years of experience in supplying and installing Focused Ion beam systems.

(Signature of the Bidder)

Printed Name

Designation, Seal Date:

Annexure-3:

Declaration regarding track record

To,
The Chairperson,
Centre for Nano Science and Engineering
Indian Institute of Science,
Bangalore – 560012, India

Ref: Tender No: XXXXXXX
Dated: XXXXX

Supply and installation of Focused Ion beam at MNCF, CeNSE, IISc Bangalore

Sir,
I've carefully gone through the Terms & Conditions contained in the above referred tender. I hereby declare that my company/ firm is not currently debarred / blacklisted by any Government / Semi Government organizations / institutions in India or abroad. I further certify that I'm competent officer in my company / firm to make this declaration.

Or

I declare the following

Sl.No	Country in which the company is Debarred /blacklisted / case is Pending	Blacklisted / debarred by Government / Semi Government/Organizations /Institutions	Reason	Since when and for how long

(NOTE: In case the company / firm was blacklisted previously, please provide the details regarding period for which the company / firm was blacklisted and the reason/s for the same).

Yours faithfully
(Signature of the Bidder)

Name
Designation, Seal

Date:

Annexure – 4:

Declaration for acceptance of terms and conditions

To,
The Chairperson,
Centre for Nano Science and Engineering
Indian Institute of Science,
Bangalore – 560012, India

Ref: Tender No: XXXXXX
Dated: XXXX

Supply and installation of Focused Ion Beam at MNCF, CeNSE, IISc Bangalore
Sir,

I've carefully gone through the Terms & Conditions as mentioned in the above referred tender document. I declare that all the provisions of this tender document are acceptable to my company. I further certify that I'm an authorized signatory of my company and am, therefore, competent to make this declaration.

Yours faithfully,

(Signature of the Bidder)

Name

Designation, Seal

Date:

Annexure – 5:

Details of items quoted:

- a. Company Name
- b. Product Name
- c. Part / Catalogue number
- d. Product description / main features
- e. Detailed technical specifications
- f. Remarks

Instructions to bidders:

1. Bidder should provide technical specifications of the quoted product/s in detail.
2. Bidder should attach product brochures along with technical bid.
3. Bidders should clearly indicate compliance or non-compliance of the technical specifications provided in the tender document.

Section 6 – Commercial Bid

The commercial bid should be furnished with all requirements of the tender with supporting documents as mentioned under:

S.No	Description	Cat. Number	Quantity	Unit Price	Sub total
1.	Essential items noted in the technical specification				
1.a	... (details of essential items)				
1.b	...				
2.	Optional items noted in the technical specification				
2.a	... (details of essential items)				
2.b	...				
3.	Accessories for operation and installation				
4.	All Consumables, spares and software to be supplied locally				
5.	Warranty (3 years)				
6.	AMC 2 years beyond warranty				
7.	Cost of Insurance and Airfreight				
8.	CIP/CIF IISc, Bengaluru				

Any additional items

S.No	Description	Cat. Number	Quantity	Unit Price	Sub total

Addressed to

The Chairperson,
Attn: Dr. Suresha S J
Centre for Nano Science and Engineering
Indian Institute of Science
Bangalore – 560012, India

Section 7 – Checklist

(This should be enclosed with technical bid- Part A)

The following items must be checked before the Bid is submitted:

1. Sealed Envelope “A”: Technical Bid

1. **Section 5- Technical Bid (each page signed by the authorized signatory and sealed) with the below annexures:**
 - a. **Annexure 1: Bidders details**
 - b. **Annexure 2: Declaration regarding experience**
 - c. **Annexure 3: Declaration regarding clean track record**
 - d. **Annexure 4: Declaration for acceptance of terms and conditions**
 - e. **Annexure 5: Details of items quoted**
2. **Copy of this tender document duly signed by the authorized signatory on every page and sealed.**

2. Sealed Envelop “B”: Commercial Bid

Section 6: Commercial Bid

Your quotation must be submitted in two envelopes: **Technical Bid (Envelope A) and Commercial Bid (Envelope B)** super scribing on both the envelopes with Tender No. and due date and both of these in sealed covers and put in a bigger cover which should also be sealed and duly super scribed with Tender No., Tender description & Due Date.